# Author index to volume 47


Bader, S.D., Magneto-optical studies of ultra-thin ferromagnetic films 47 (1992) 355
Barnard, J.A., see Haftek 47 (1992) 400
Barshatzky, H., see Isaacson 47 (1992) 15
Batson, P.E., Spatial resolution in electron energy loss spectroscopy 47 (1992) 133
Bauer, E., see Pinkvos 47 (1992) 339
Baumann, F.H., M. Bode, Y. Kim and A. Ourmazd, Quantitative chemical mapping: spatial resolution 47 (1992) 167
Bode, M., see Baumann 47 (1992) 167
Brown, J.E., see Grovenor 47 (1992) 199

Carcia, P.F., see Li 47 (1992) 313
Cerezo, A., see Grovenor 47 (1992) 199
Cerezo, A., see Petford-Long 47 (1992) 367
Chamberlin, R.V., see DiCarlo 47 (1992) 383
Chamberlin, R.V. and M.R. Scheinfein, Slow relaxation in magnetic materials 47 (1992) 408
Chambliss, D.D., see Wilson 47 (1992) 212
Chapman, J.N., R. Ploessl and D.M. Donnet, Differential phase contrast microscopy of magnetic materials 47 (1992) 331
Chiang, S., see Wilson 47 (1992) 212
Cline, J., see Isaacson 47 (1992) 15
Cowley, J.M., Resolution limitation in the electron microscopy of surfaces 47 (1992) 187

De Jong, A.F., see Van Dyck 47 (1992) 266
Demczyk, B.G., Evolution of microstructure and magnetic properties in magnetron-sputtered CoCr thin films 47 (1992) 425
DiCarlo, A., M.R. Scheinfein and R.V. Chamberlin, Magnetic force microscope utilizing an ultra-small-spring-constant vertically cantilevered tip 47 (1992) 383
Donnet, D.M., see Chapman 47 (1992) 331
Donovan, P.E., see Petford-Long 47 (1992) 323
Downing, K.H., see Glaeser 47 (1992) 256

Glaeser, R.M. and K.H. Downing, Assessment of resolution in biological electron crystallography 47 (1992) 256
Goldstein, J.I., see Williams 47 (1992) 121
Griffith, O.H., see Rempfer 47 (1992) 35

Elsevier Science Publishers B.V.

Grovenor, C.R.M., G.D.W. Smith, A. Cerezo, J.A. Liddle, R.A.D. Mackenzie, P.J. Warren, R.P. Setna, J.M. Hyde, J.E. Brown, I. Stark and B.A. Shollock, Ultra-high-resolution chemical analysis by field-ion microscopy, atom probe and position-sensitive atom-probe techniques 47 (1992) 199
Grütter, P., D. Rugar and H.J. Mamin, Magnetic force microscopy of magnetic materials 47 (1992) 393

Haftek, E., M. Tan and J.A. Barnard, Microstructure and magnetic properties of ferromagnetic Fe–Sn alloy thin films 47 (1992) 400
Hallmark, V.M., see Wilson 47 (1992) 212
Hembree, G.G. and J.A. Venables, Nanometer-resolution scanning Auger electron microscopy 47 (1992) 109
Heys, A., see Petford-Long 47 (1992) 323
Howe, J.M., see Sarikaya 47 (1992) 145
Hurst, J., see Pinkvos 47 (1992) 339
Hütten, A. and G. Thomas, Microstructural parameters of melt-spun $Nd_{15}Fe_{77}B_8$ ribbons 47 (1992) 447
Hyde, J.M., see Grovenor 47 (1992) 199
Hyde, J.M., see Petford-Long 47 (1992) 367

Isaacson, M., J. Cline and H. Barshatzky, Resolution in near-field optical microscopy 47 (1992) 15

Jacobsen, C., J. Kirz and S. Williams, Resolution in soft X-ray microscopes 47 (1992) 55
Jansen, H.J.F., see Peng 47 (1992) 361
Joy, D.C. and J.B. Pawley, High-resolution scanning electron microscopy 47 (1992) 80

Kim, Y., see Baumann 47 (1992) 167
Kirz, J., see Jacobsen 47 (1992) 55
Knobler, C.M., see Stine 47 (1992) 23

Li, Z.G. and P.F. Carcia, HREM contributions to microstructural characterization of Pt/Co ultra-thin magnetic multilayers 47 (1992) 313
Lichte, H., Electron holography. I. Can electron holography reach 0.1 nm resolution? 47 (1992) 223

high resolution electron holography into materials science 47 (1992) 231
Liddle, J.A., see Grovenor 47 (1992) 199
Lippel, P.H., see Wilson 47 (1992) 212
Loane, R.F., see Silcox 47 (1992) 173

Mackenzie, R.A.D., see Grovenor 47 (1992) 199
Mamin, H.J., see Grütter 47 (1992) 393
Michael, J.R., see Williams 47 (1992) 121
Modak, A.R., S.S.P. Parkin and D.J. Smith, Transmission electron microscopy observations of magnetic multilayers 47 (1992) 375
Munro, E., see Wells 47 (1992) 101

Nolan, T.P., R. Sinclair, R. Ranjan and T. Yamashita, Microstructure and crystallography of textured CoCrTa/Cr recording media 47 (1992) 437

O'Keefe, M.A., "Resolution" in high-resolution electron microscopy 47 (1992) 282
Ourmazd, A., see Baumann 47 (1992) 167

Parkin, S.S.P., see Modak 47 (1992) 375
Pawley, J.B., see Joy 47 (1992) 80
Peng, S.S. and H.J.F. Jansen, Structural and magnetic properties of tetragonally distorted iron 47 (1992) 361
Petford-Long, A.K., P.E. Donovan and A. Heys, Microstructure of Gd/W magnetic multilayered films 47 (1992) 323
Petford-Long, A.K., A. Cerezo and J.M. Hyde, Atom probe analysis and modelling of interfaces in magnetic multilayers 47 (1992) 367
Pinkvos, H., H. Poppa, E. Bauer and J. Hurst, Spin-polarized low-energy electron microscopy study of the magnetic microstructure of ultra-thin epitaxial cobalt films on W(110) 47 (1992) 339
Ploessl, R., see Chapman 47 (1992) 331
Poppa, H., see Pinkvos 47 (1992) 339
Prinz, G.A., Magnetic anisotropy in epitaxial metal films 47 (1992) 346

Ranjan, R., see Nolan 47 (1992) 437
Rempfer, G.F. and O.H. Griffith, Emission microscopy and related techniques: resolution in photoelectron microscopy, low energy electron microscopy and mirror electron microscopy 47 (1992) 35
Rempfer, G.F., Methods of calculating resolution in electron microscopy: Scherzer's equation, circles of least confusion and the intensity distribution approach 47 (1992) 241

Sarikaya, M., Preface to Resolution in the Microscope 47 (1992) vii
Sarikaya, M., Evolution of resolution in microscopy 47 (1992) 1
Sarikaya, M. and J.M. Howe, Resolution in conventional transmission electron microscopy 47 (1992) 145
Scheerschmidt, K., see Lichte 47 (1992) 231
Scheinfein, M.R. and D.J. Smith, Foreword to Microstructure of Magnetic Materials 47 (1992) 309
Scheinfein, M.R., see DiCarlo 47 (1992) 383
Scheinfein, M.R., see Chamberlin 47 (1992) 408
Setna, R.P., see Grovenor 47 (1992) 199
Shollock, B.A., see Grovenor 47 (1992) 199
Silcox, J., P. Xu and R.F. Loane, Resolution limits in annular dark field STEM 47 (1992) 173
Sinclair, R., see Nolan 47 (1992) 437
Smith, D.J., see Scheinfein 47 (1992) 309
Smith, D.J., see Modak 47 (1992) 375
Smith, G.D.W., see Grovenor 47 (1992) 199
Stark, I., see Grovenor 47 (1992) 199
Steeds, J.W. and R. Vincent, Prospects for convergent beam electron diffraction with 200–300 kV cold field emission transmission electron microscopes 47 (1992) 162
Stine, K.J. and C.M. Knobler, Fluorescence microscopy: a tool for studying the physical chemistry of interfaces 47 (1992) 23

Tan, M., see Haftek 47 (1992) 400
Thomas, G., see Hütten 47 (1992) 447
Tonomura, A., Electron holography of magnetic materials and observation of flux-line dynamics 47 (1992) 419

Van den Bos, A., Ultimate resolution: a mathematical framework 47 (1992) 298
Van Dyck, D. and A.F. de Jong, Ultimate resolution and information in electron microscopy: general principles 47 (1992) 266
Venables, J.A., see Hembree 47 (1992) 109
Victora, R.H., Magnetism, magnetics and microstructure 47 (1992) 318
Vincent, R., see Steeds 47 (1992) 162
Völkl, E., see Lichte 47 (1992) 231

Warren, P.J., see Grovenor 47 (1992) 199
Wells, O.C. and E. Munro, Magnetically filtered low-loss scanning electron microscopy 47 (1992) 101
Williams, D.B., J.R. Michael, J.I. Goldstein and A.D. Romig, Jr., Definition of the spatial resolution of X-ray microanalysis in thin foils 47 (1992) 121

Chambliss and V.M. Hallmark, Resolution in the scanning tunneling microscope 47 (1992) 212

Yamashita, T., see Nolan 47 (1992) 437

# Subject index to volume 47


**Analytical microscopy**

Magnetically filtered low-loss scanning electron microscopy, *Wells and Munro* 47 (1992) 101

Definition of the spatial resolution of X-ray microanalysis in thin foils, *Williams, Michael, Goldstein and Romig, Jr.* 47 (1992) 121

Quantitative chemical mapping: spatial resolution, *Baumann, Bode, Kim and Ourmazd* 47 (1992) 167

Ultra-high-resolution chemical analysis by field-ion microscopy, atom probe and position-sensitive atom-probe techniques, *Grovenor, Smith, Cerezo, Liddle, Mackenzie, Warren, Setna, Hyde, Brown, Stark and Shollock* 47 (1992) 199

HREM contributions to microstructural characterization of Pt/Co ultra-thin magnetic multilayers, *Li and Carcia* 47 (1992) 313

Atom probe analysis and modelling of interfaces in magnetic multilayers, *Petford-Long, Cerezo and Hyde* 47 (1992) 367

**Conventional electron microscopy**

Resolution in conventional transmission electron microscopy, *Sarikaya and Howe* 47 (1992) 145

**Diffraction and optical diffraction**

Prospects for convergent beam electron diffraction with 200–300 kV cold field emission transmission electron microscopes, *Steeds and Vincent* 47 (1992) 162

Assessment of resolution in biological electron crystallography, *Glaeser and Downing* 47 (1992) 256

**Electron energy loss spectroscopy**

Magnetically filtered low-loss scanning electron microscopy, *Wells and Munro* 47 (1992) 101

Spatial resolution in electron energy loss spectroscopy, *Batson* 47 (1992) 133

**High resolution**

Evolution of resolution in microscopy, *Sarikaya* 47 (1992) 1

High-resolution scanning electron microscopy, *Joy and Pawley* 47 (1992) 80

Resolution in conventional transmission electron microscopy, *Sarikaya and Howe* 47 (1992) 145

Ultra-high-resolution chemical analysis by field-ion microscopy, atom probe and position-sensitive atom-probe techniques, *Grovenor, Smith, Cerezo, Liddle, Mackenzie, Warren, Setna, Hyde, Brown, Stark and Shollock* 47 (1992) 199

Assessment of resolution in biological electron crystallography, *Glaeser and Downing* 47 (1992) 256

Ultimate resolution and information in electron microscopy: general principles, *Van Dyck and De Jong* 47 (1992) 266

"Resolution" in high-resolution electron microscopy, *O'Keefe* 47 (1992) 282

HREM contributions to microstructural characterization of Pt/Co ultra-thin magnetic multilayers, *Li and Carcia* 47 (1992) 313

Transmission electron microscopy observations of magnetic multilayers, *Modak, Parkin and Smith* 47 (1992) 375

**Holography**

Electron holography. I. Can electron holography reach 0.1 nm resolution?, *Lichte* 47 (1992) 223

Electron holography. II. First steps of high resolution electron holography into materials science, *Lichte, Völkl and Scheerschmidt* 47 (1992) 231

Electron holography of magnetic materials and observation of flux-line dynamics, *Tonomura* 47 (1992) 419

**Instrumentation**

Nanometer-resolution scanning Auger electron microscopy, *Hembree and Venables* 47 (1992) 109

Magnetic force microscope utilizing an ultra-small-spring-constant vertically cantilevered tip, *DiCarlo, Scheinfein and Chamberlin* 47 (1992) 383

**Low energy electron microscopy, photoemission microscopy**

Emission microscopy and related techniques: resolution in photoelectron microscopy, low energy electron microscopy and mirror electron microscopy, *Rempfer and Griffith* 47 (1992) 35


Elsevier Science Publishers B.V.

crostructure of ultra-thin epitaxial cobalt films on W(110), *Pinkvos, Poppa, Bauer and Hurst* 47 (1992) 339

**Methods and techniques**

Fluorescence microscopy: a tool for studying the physical chemistry of interfaces, *Stine and Knobler* 47 (1992) 23

Quantitative chemical mapping: spatial resolution, *Baumann, Bode, Kim and Ourmazd* 47 (1992) 167

Assessment of resolution in biological electron crystallography, *Glaeser and Downing* 47 (1992) 256

Differential phase contrast microscopy of magnetic materials, *Chapman, Ploessl and Donnet* 47 (1992) 331

Magnetic force microscope utilizing an ultra-small-spring-constant vertically cantilevered tip, *DiCarlo, Scheinfein and Chamberlin* 47 (1992) 383

**New developments**

Evolution of resolution in microscopy, *Sarikaya* 47 (1992) 1

Resolution in soft X-ray microscopes, *Jacobsen, Kirz and Williams* 47 (1992) 55

Nanometer-resolution scanning Auger electron microscopy, *Hembree and Venables* 47 (1992) 109

Prospects for convergent beam electron diffraction with 200–300 kV cold field emission transmission electron microscopes, *Steeds and Vincent* 47 (1992) 162

Magnetism, magnetics and microstructure, *Victora* 47 (1992) 318

Microstructure of Gd/W magnetic multilayered films, *Petford-Long, Donovan and Heys* 47 (1992) 323

Differential phase contrast microscopy of magnetic materials, *Chapman, Ploessl and Donnet* 47 (1992) 331

Spin-polarized low-energy electron microscopy study of the magnetic microstructure of ultra-thin epitaxial cobalt films on W(110), *Pinkvos, Poppa, Bauer and Hurst* 47 (1992) 339

Magnetic anisotropy in epitaxial metal films, *Prinz* 47 (1992) 346

Magneto-optical studies of ultra-thin ferromagnetic films, *Bader* 47 (1992) 355

Structural and magnetic properties of tetragonally distorted iron, *Peng and Jansen* 47 (1992) 361

Magnetic force microscopy of magnetic materials, *Grütter, Rugar and Mamin* 47 (1992) 393

Electron holography of magnetic materials and observation of flux-line dynamics, *Tonomura* 47 (1992) 419

**Particle optics, theory**

Methods of calculating resolution in electron microscopy: Scherzer's equation, circles of least confusion and the intensity distribution approach, *Rempfer* 47 (1992) 241

Ultimate resolution: a mathematical framework, *Van den Bos* 47 (1992) 298

**Scanning electron microscopy**

High-resolution scanning electron microscopy, *Joy and Pawley* 47 (1992) 80

Magnetically filtered low-loss scanning electron microscopy, *Wells and Munro* 47 (1992) 101

**Scanning probe microscopy**

Resolution in near-field optical microscopy, *Isaacson, Cline and Barshatzky* 47 (1992) 15

Definition of the spatial resolution of X-ray microanalysis in thin foils, *Williams, Michael, Goldstein and Romig, Jr.* 47 (1992) 121

Ultra-high-resolution chemical analysis by field-ion microscopy, atom probe and position-sensitive atom-probe techniques, *Grovenor, Smith, Cerezo, Liddle, Mackenzie, Warren, Setna, Hyde, Brown, Stark and Shollock* 47 (1992) 199

Atom probe analysis and modelling of interfaces in magnetic multilayers, *Petford-Long, Cerezo and Hyde* 47 (1992) 367

Magnetic force microscope utilizing an ultra-small-spring-constant vertically cantilevered tip, *DiCarlo, Scheinfein and Chamberlin* 47 (1992) 383

Magnetic force microscopy of magnetic materials, *Grütter, Rugar and Mamin* 47 (1992) 393

**Scanning transmission electron microscopy**

Resolution limits in annular dark field STEM, *Silcox, Xu and Loane* 47 (1992) 173

Differential phase contrast microscopy of magnetic materials, *Chapman, Ploessl and Donnet* 47 (1992) 331

**Scanning tunneling microscopy**

Resolution in the scanning tunneling microscope, *Wilson, Lippel, Chiang, Chambliss and Hallmark* 47 (1992) 212

the physical chemistry of interfaces, *Stine and Knobler* 47 (1992) 23
Resolution limitation in the electron microscopy of surfaces, *Cowley* 47 (1992) 187
HREM contributions to microstructural characterization of Pt/Co ultra-thin magnetic multilayers, *Li and Carcia* 47 (1992) 313
Magnetism, magnetics and microstructure, *Victora* 47 (1992) 318
Microstructure of Gd/W magnetic multilayered films, *Petford-Long, Donovan and Heys* 47 (1992) 323
Spin-polarized low-energy electron microscopy study of the magnetic microstructure of ultra-thin epitaxial cobalt films on W(110), *Pinkvos, Poppa, Bauer and Hurst* 47 (1992) 339
Magnetic anisotropy in epitaxial metal films, *Prinz* 47 (1992) 346
Magneto-optical studies of ultra-thin ferromagnetic films, *Bader* 47 (1992) 355
Structural and magnetic properties of tetragonally distorted iron, *Peng and Jansen* 47 (1992) 361
Atom probe analysis and modelling of interfaces in magnetic multilayers, *Petford-Long, Donovan and Smith* 47 (1992) 375
Microstructure and magnetic properties of ferromagnetic Fe–Sn alloy thin films, *Haftek, Tan and Barnard* 47 (1992) 400
Evolution of microstructure and magnetic properties in magnetron-sputtered CoCr thin films, *Demczyk* 47 (1992) 425
Microstructure and crystallography of textured CoCrTa/Cr recording media, *Nolan, Sinclair, Ranjan and Yamashita* 47 (1992) 437
Microstructural parameters of melt-spun $Nd_{15}Fe_{77}B_8$ ribbons, *Hütten and Thomas* 47 (1992) 447

**Theory of scanning probes**

Resolution in near-field optical microscopy, *Isaacson, Cline and Barshatzky* 47 (1992) 15

**Abstracts / Announcements / Book reviews / Comments / Editorials / Reports**

Preface to Resolution in the Microscope, *Sarikaya* 47 (1992) vii
Foreword to Microstructure of Magnetic Materials, *Scheinfein and Smith* 47 (1992) 309